

## Features

- Low  $R_{DS(ON)}$
- Green Device Available
- 100% EAS Tested
- Advanced Trench MOS Technology

## Applications

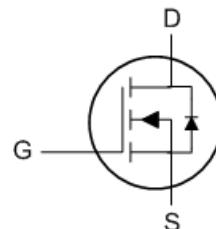
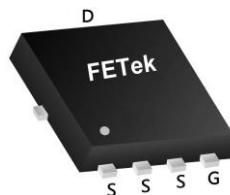
- Power Management in TV Converter.
- DC/DC Converter.

## Product Summary



BVDSS	RDS(on)	ID
150V	56mΩ	23A

## PRPAK5X6 Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	150	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current <sup>1</sup>	23	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current <sup>1</sup>	16	A
$I_D @ T_A = 25^\circ C$	Continuous Drain Current <sup>1</sup>	4.5	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current <sup>1</sup>	3.8	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	60	A
$P_D @ T_C = 25^\circ C$	Total Power Dissipation <sup>3</sup>	72.6	W
$P_D @ T_A = 25^\circ C$	Total Power Dissipation <sup>3</sup>	2.7	W
$T_{STG}$	Storage Temperature Range	-55 to 175	°C
$T_J$	Operating Junction Temperature Range	-55 to 175	°C

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient <sup>1</sup>	---	55	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	2.0	°C/W



FETek Technology Corp.

FKBA20N15S

N-Ch 150V Fast Switching MOSFETs

Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	150	---	---	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{\text{GS}}=10\text{V}$ , $I_D=10\text{A}$	---	47	56	$\text{m}\Omega$
	Static Drain-Source On-Resistance <sup>2</sup>	$V_{\text{GS}}=4.5\text{V}$ , $I_D=10\text{A}$	---	53	68	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D=250\mu\text{A}$	1.2	---	2.5	V
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=120\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	1	$\text{uA}$
		$V_{\text{DS}}=120\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=55^\circ\text{C}$	---	---	5	
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm 100$	nA
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=5\text{V}$ , $I_D=10\text{A}$	---	25	---	S
$Q_g$	Total Gate Charge	$V_{\text{DS}}=75\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=10\text{A}$	---	19	---	nC
$Q_{\text{gs}}$	Gate-Source Charge		---	4.5	---	
$Q_{\text{gd}}$	Gate-Drain Charge		---	2.6	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}=75\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $R_G=3.3\Omega$	---	18	---	ns
$T_r$	Rise Time		---	5.8	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	26.5	---	
$T_f$	Fall Time		---	4.5	---	
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=25\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	1090	---	pF
$C_{\text{oss}}$	Output Capacitance		---	93	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	6	---	

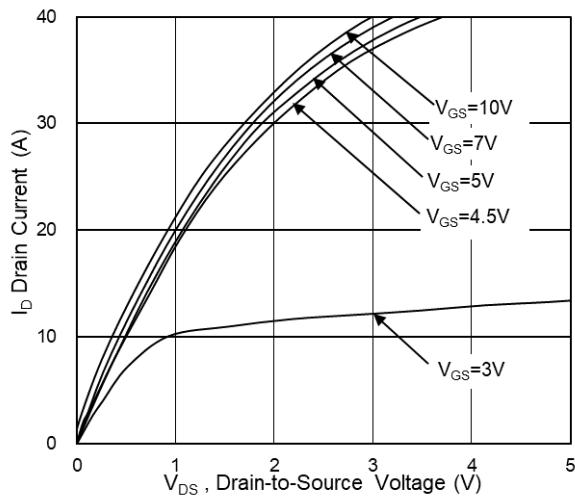
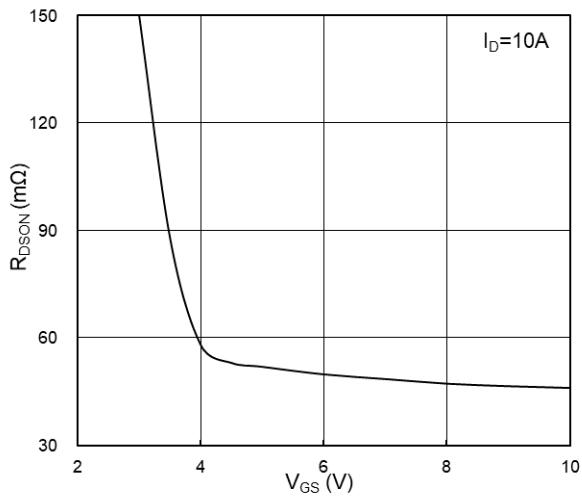
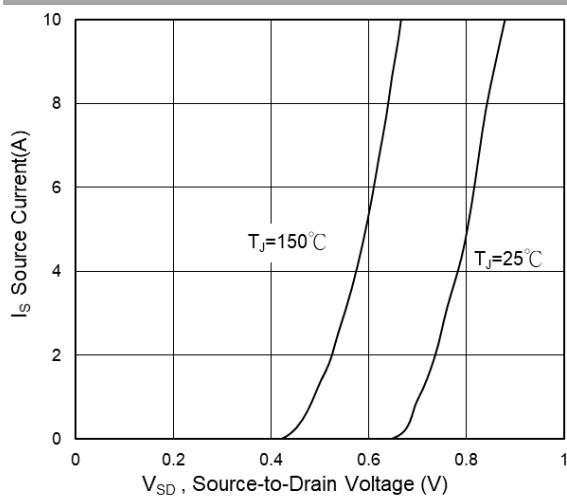
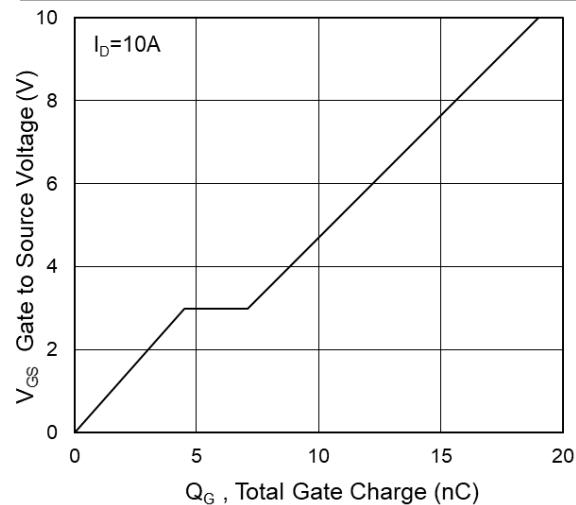
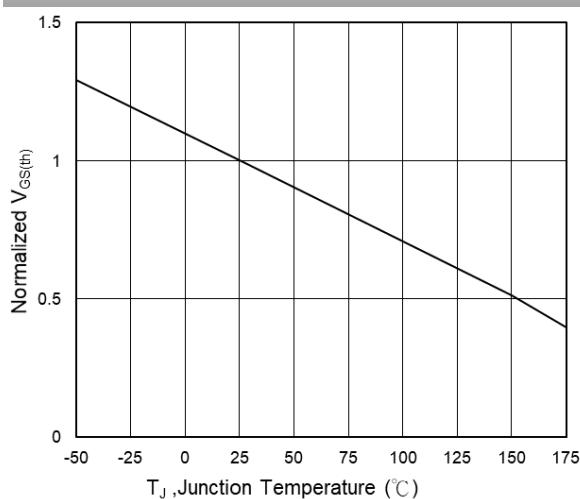
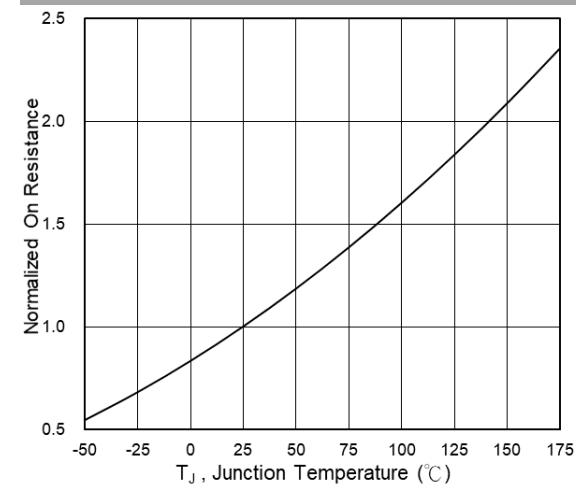
## Diode Characteristics

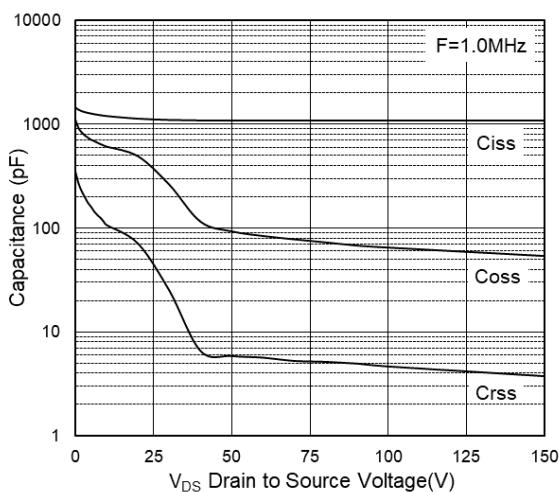
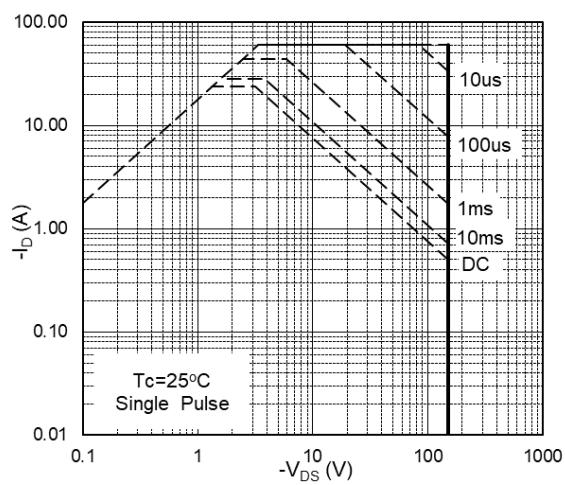
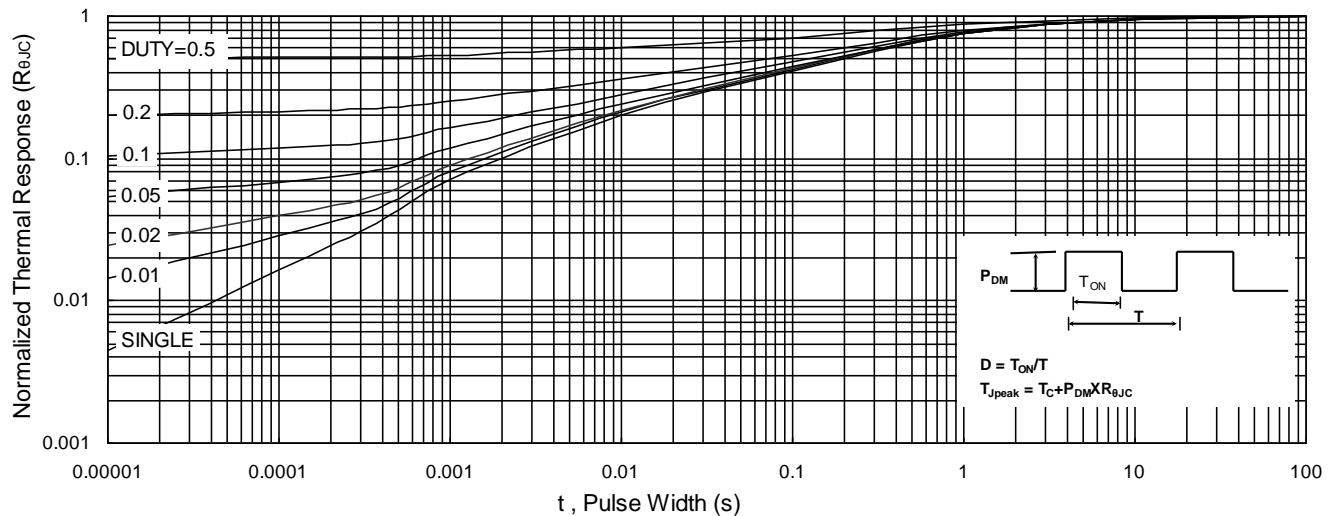
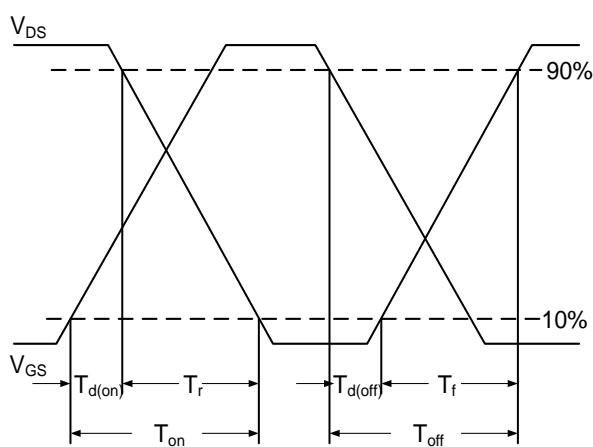
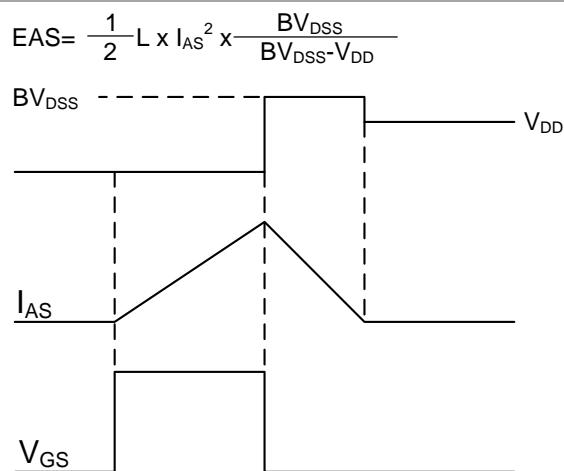
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current <sup>1,4</sup>	$V_G=V_D=0\text{V}$ , Force Current	---	---	20	A
$V_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$V_{\text{GS}}=0\text{V}$ , $I_s=1\text{A}$ , $T_J=25^\circ\text{C}$	---	---	1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_F=10\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$	---	45	---	nS
	Reverse Recovery Charge		---	138	---	nC

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 4.The data is theoretically the same as  $I_D$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.

### Typical Characteristics


**Fig.1 Typical Output Characteristics**

**Fig.2 On-Resistance vs G-S Voltage**

**Fig.3 Source Drain Forward Characteristics**

**Fig.4 Gate-Charge Characteristics**

**Fig.5 Normalized  $V_{GS(th)}$  vs  $T_J$** 

**Fig.6 Normalized  $R_{DS(on)}$  vs  $T_J$**

**N-Ch 150V Fast Switching MOSFETs**

**Fig.7 Capacitance**

**Fig.8 Safe Operating Area**

**Fig.9 Normalized Maximum Transient Thermal Impedance**

**Fig.10 Switching Time Waveform**

**Fig.11 Unclamped Inductive Switching Waveform**